



a cert 

# CERTIFICATE

#### Issued Date: March 17, 2011 Report No.: 113121R-ITCEP07V05

This is to certify that the following designated product

Product	:	Network Camera
Trade name	:	VIVOTEK
Model Number	:	SD8111, SD8121
Compa <mark>ny Name</mark>	:	VIVOTEK INC.

This product, which has been issued the test report listed as above in QuieTek Laboratory, is based on a single evaluation of one sample and confirmed to comply with the requirements of the following EMC standard.

EN 55022: 2006+A1: 2007 EN 61000-3-2: 2006+A2: 2009 EN 61000-3-3: 2008 AS/NZS CISPR 22: 2009 EN 55024: 1998+A1: 2001+A2: 2003 IEC 61000-4-2: 2008 IEC 61000-4-3: 2008 IEC 61000-4-4: 2004 IEC 61000-4-5: 2005 IEC 61000-4-6: 2008 IEC 61000-4-8: 2009 IEC 61000-4-11: 2004

TEST LABORATORY

Vincent Lin / Manager

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**QuieTek** No. 5-22, Rueishu Keng, Linkou Dist., New Taipei City 24451, Taiwan. R.O.C. TEL: +886-2-8601-3788 FAX: +886-2-8601-3789 Email: service@quietek.com http://www.quietek.com



Product Name	:	Network	Camera
Model No.	:	SD8111,	SD8121

Applicant	:	VIVOTEK INC.
Address	:	6F, No.192, Lien-Cheng Rd., Chung-Ho,
		New Taipei City, 235, Taiwan, R.O.C.

Date of Receipt	: 2011/03/08
Issued Date	: 2011/03/17
Report No.	: 113121R-ITCEP07V05
Report Version	: V1.0

The test results relate only to the samples tested.

The test results shown in the test report are traceable to the national/international standard through the calibration of the equipment and evaluated measurement uncertainty herein.

This report must not be used to claim product endorsement by TAF, NVLAP or any agency of the Government. The test report shall not be reproduced except in full without the written approval of QuieTek Corporation.

# **CE** Declaration of Conformity

We herewith confirm the following designated products to comply with the requirements set out in the Council Directive on the approximation of the laws of the Member States relating to Electromagnetic Compatibility Directive (2004/108/EC) with applicable standards listed below.

Product	: Network Camera
Trade name	: VIVOTEK
Model Number	: SD8111, SD8121
Applicable Harmonized	: EN 55022: 2006+A1: 2007, Class A
Standards under Directive	EN 55024: 1998+A1: 2001+A2: 2003
2004/108/EC	EN 61000-3-2:2006+A2: 2009, Class A
	EN 61000-3-3:2008

Company Name	:	
Company Address	:	
Telephone	:	Facsimile :

Person in responsible for marking this declaration:

Name (Full Name)

Title/ Department

Date

Legal Signature



Accredited by NVLAP, TAF-CNLA, DNV, TUV, Nemko

Date: March 17, 2011 QTK No.: 113121R-ITCEP07V05

# **CE** Statement of Conformity

This statement is to certify that the designated product below.

Product	:	Network Camera
Trade name	:	VIVOTEK
Model Number	:	SD8111, SD8121
Company Name	:	VIVOTEK INC.
Applicable Standards	:	EN 55022: 2006+A1: 2007, Class A
		EN 55024: 1998+A1: 2001+A2: 2003
		EN 61000-3-2:2006+A2: 2009, Class A
		EN 61000-3-3:2008

One sample of the designated product has been tested and evaluated in our laboratory to find in compliance with the applicable standards above. The issued test report(s) show(s) it in detail.

Report Number : 113121R-ITCEP07V05



**TEST LABORATORY** 

Vincent Lin / Manager

The verification is based on a single evaluation of one sample of above-mentioned products. It does not imply an assessment of the whole production and does not permit the use of the test lab. Logo.



Test Report Certification Issued Date : 2011/03/17 Report No. : 113121R-ITCEP07V05			
	QuieTek		
Product Name	: Network Camera		
Applicant	: VIVOTEK INC.		
Address	: 6F, No.192, Lien-Cheng Rd., Chung-Ho, New Taipei City, 235,		
Manufacturor			
Model No	· SD8111_SD8121		
EUT Rated Voltage	: AC 100-240V, 50-60Hz		
EUT Test Voltage	: AC 230V / 50Hz		
Trade Name	: VIVOTEK		
Applicable Standard	: EN 55022: 2006+A1: 2007, Class A		
	EN 55024: 1998+A1: 2001+A2: 2003		
	EN 61000-3-2:2006+A2: 2009		
	EN 61000-3-3:2008		
	AS/NZS CISPR 22: 2009		
Test Result	: Complied		
Performed Location	: Quietek Corporation (Linkou Laboratory)		
	No. 5-22, Rueishu Keng, Linkou Dist., New Taipei City 24451,		
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	(Manager / Vincent Lin)		

# Laboratory Information

We, **QuieTek Corporation**, are an independent EMC and safety consultancy that was established the whole facility in our laboratories. The test facility has been accredited/accepted (audited or listed) by the following related bodies in compliance with ISO 17025, EN 45001 and specified testing scopes:

Taiwan R.O.C.	:	BSMI, NCC, TAF
Germany	:	TUV Rheinland
Norway	:	Nemko, DNV
USA	:	FCC, NVLAP
Japan	:	VCCI

The related certificate for our laboratories about the test site and management system can be downloaded from QuieTek Corporation's Web Site : <u>http://www.quietek.com/tw/ctg/cts/accreditations.htm</u> The address and introduction of QuieTek Corporation's laboratories can be founded in our Web site : <u>http://www.quietek.com/</u>

If you have any comments, Please don't hesitate to contact us. Our contact information is as below:

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### 1. General Information

# 1.1. EUT Description

Product Name	Network Camera
Trade Name	VIVOTEK
Model No.	SD8111, SD8121

Component				
Power Adapter MFR: L.T.E., M/N: LTE60E-S2-1				
	Input: AC 100-240V, 47-63Hz, 2A			
	Output: DC 12V, 5A, MAX: 60W			
Cable Out: Non-shielded, 1.2m				

- 1. This appendix report was based on Quietek report No. 108328R-ITCEP07V05. The different is adding Adapter.
- 2. The different for the Sensor is shown as below:

Model Number	Description	
SD8111	For NTSC	
SD8121	For PAL	

# 1.2. Mode of Operation

QuieTek has verified the construction and function in typical operation. All the test modes were carried out with the EUT in normal operation, which was shown in this test report and defined as:

Pre-Test Mode			
Mode 1: Normal Operation			
Final Test Mode			
Emission	Mode 1: Normal Operation		
Immunity	Mode 1: Normal Operation		



## 1.3. Tested System Details

The types for all equipments, plus descriptions of all cables used in the tested system (including inserted cards) are:

Pro	duct	Manufacturer	Model No.	Serial No.	Power Cord
1	Monitor	SONY	PVM-14M2U	2111389	Non-Shielded, 1.8m
2	Microphone &	PCHOME	N/A	N/A	N/A
	Earphone (EMI)				
	Microphone &	Ergotech	ET-E201	N/A	
	Earphone (EMS)				
3	Notebook PC	DELL	D630	00144-023-351-283	Non-Shielded, 1.8m



## 1.4. Configuration of Tested System





# 1.5. EUT Exercise Software

1	Setup the EUT and simulators as shown on 1.4.			
2	Turn on the power of all equipment.			
3	The EUT will start to operate and display the video figure from the signal source.			
4	The EUT will display "video figure" on monitor.			
5	Repeat the above procedure (3) to (4).			

# 2. Technical Test

### 2.1. Summary of Test Result

 $\boxtimes$  No deviations from the test standards

Deviations from the test standards as below description:

Emission				
Dorformed Item		Test	Doviation	
Penomed liem	Normative References	Performed	Deviation	
Conducted Emission	EN 55022: 2006+A1: 2007	Yes	No	
	AS/NZS CISPR 22: 2009			
Impedance Stabilization Network	EN 55022: 2006+A1: 2007	Yes	No	
	AS/NZS CISPR 22: 2009			
Radiated Emission	EN 55022: 2006+A1: 2007	Yes	No	
	AS/NZS CISPR 22: 2009			
Power Harmonics	EN 61000-3-2:2006+A2: 2009	Yes	No	
Voltage Fluctuation and Flicker	EN 61000-3-3:2008	Yes	No	

Immunity					
Porformod Itom	Normativo Poforonaco	Test	Doviation		
	Normalive References	Performed	Deviation		
Electrostatic Discharge	IEC 61000-4-2: 2008	Yes	No		
Radiated susceptibility	IEC 61000-4-3: 2008	Yes	No		
Electrical fast transient/burst	IEC 61000-4-4: 2004	Yes	No		
Surge	IEC 61000-4-5: 2005	Yes	No		
Conducted susceptibility	IEC 61000-4-6: 2008	Yes	No		
Power frequency magnetic field	IEC 61000-4-8: 2009	Yes	No		
Voltage dips and interruption	IEC 61000-4-11: 2004	Yes	No		



# 2.2. List of Test Equipment

#### Conducted Emission / SR1

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
EMI Test Receiver	R&S	ESCS 30	100366	2010/10/29
LISN	R&S	ENV4200	833209/007	2010/08/14
LISN	R&S	ENV216	100085	2011/02/17
Pulse Limiter	R&S	ESH3-Z2	357.88.10.52	2010/09/10

#### Impedance Stabilization Network / SR1

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
Capacitive Voltage Probe	Schaffner	CVP2200A	18331	2010/11/16
EMI Test Receiver	R&S	ESCS 30	100366	2010/10/29
LISN	R&S	ENV216	100085	2011/02/17
LISN	R&S	ENV4200	833209/007	2010/08/14
Pulse Limiter	R&S	ESH3-Z2	357.88.10.52	2010/09/10
RF Current Probe	FCC	F-65 10KHz~1GHz	198	2010/11/13
BALANCED TELECOM ISN	FCC	FCC-TLISN-T2-02	20316	2010/11/22
BALANCED TELECOM ISN	FCC	FCC-TLISN-T4-02	20317	2010/11/22
BALANCED TELECOM ISN	FCC	FCC-TLISN-T8-02	20319	2010/11/22

#### Radiated Emission / Site3

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
Bilog Antenna	Schaffner Chase	CBL6112B	2704	2010/08/01
Broadband Horn Antenna	Schwarzbeck	BBHA9170	209	2010/10/27
EMI Test Receiver	R&S	ESCS 30	100149	2011/02/09
Horn Antenna	Schwarzbeck	BBHA9120D	305	2010/08/26
Pre-Amplifier	QTK	N/A	N/A	2010/08/01
Spectrum Analyzer	Advantest	R3162	100803470	2010/11/24
EMI Test Receiver	R&S	ESI 26	838786/004	2010/06/26
Pre-Amplifier	MITEQ	QMF-4D-18040 0-45-6P	925974	2011/01/03

#### Radiated Emission / 9x6x6\_Chamber

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
Spectrum Analyzer (9K-26.5GHz)	Agilent	E4408B	MY45102743	2010/08/12
Horn Antenna	Schwarzbeck	9120D	576	2010/10/21
Pre-Amplifier	QuieTek	AP-180C	CHM/071920	2010/08/04

#### Power Harmonics / SR3

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
AC Power Source(Harmonic)	Schaffner	NSG 1007	HK54148	2010/08/11
IEC1000-4-X Analyzer(Flicker)	Schaffner	CCN 1000-1	X7 1887	2010/08/11

#### Voltage Fluctuation and Flicker / SR3

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
AC Power Source(Harmonic)	Schaffner	NSG 1007	HK54148	2010/08/11
IEC1000-4-X Analyzer(Flicker)	Schaffner	CCN 1000-1	X7 1887	2010/08/11



#### Electrostatic Discharge / SR6

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
ESD Simulator System	Noiseken	TC-815R	ESS0929097	2010/08/30
Horizontal Coupling Plane(HCP)	QuieTek	HCP AL50	N/A	N/A
Vertical Coupling Plane(VCP)	QuieTek	VCP AL50	N/A	N/A

#### Radiated susceptibility / CB5

Instrument	Manufacturer	Туре No.	Serial No	Cal. Date
AF-BOX	R&S	AF-BOX ACCUST	100007	N/A
Audio Analyzer	R&S	UPL 16	100137	2010/04/15
Biconilog Antenna	EMCO	3149	00071675	N/A
Directional Coupler	A&R	DC 6180	22735	N/A
Dual Microphone Supply	B&K	5935	2426784	2010/04/16
Mouth Simulator	B&K	4227	2439692	2010/04/16
Power Amplifier	A&R	30S1G3	309453	N/A
Power Amplifier	A&R	100W10000M7	A285000010	N/A
Power Amplifier	SCHAFFNER	CBA9413B	4020	N/A
Power Amplifier	AR	75A250A	0325371	N/A
Power Meter	R&S	NRVD(P.M)	100219	2010/04/16
Pre-Amplifier	A&R	150A220	23067	N/A
Probe Microphone	B&K	4182	2278070	2010/04/16
Signal Generator	R&S	SML03	103330	2010/04/16

#### Electrical fast transient/burst / SR3

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
TRANSIENT TEST	EMC PARTNER	TRA2000IN6	1138	2010/12/09
SYSTEM				

#### Surge / SR3

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
TRANSIENT TEST	EMC PARTNER	TRA2000IN6	1138	2010/12/09
SYSTEM				

#### Conducted susceptibility / SR6

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
Schaffner NSG 2070 RF-Generator	Schaffner	N/A	N/A	2010/04/21

#### Power frequency magnetic field / SR3

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
Induction Coil Interface	Schaffner	INA 2141	6002	N/A
Magnetic Loop Coil	Schaffner	INA 702	160	N/A
Triaxial ELF Magnetic Field Meter	F.B.BELL	4090	114135	2010/03/27

#### Voltage dips and interruption / SR3

Instrument	Manufacturer	Туре No.	Serial No	Cal. Date
TRANSIENT TEST	EMC PARTNER	TRA2000IN6	1138	2010/12/09
SYSTEM				



Schaffner NSG 2070 RF-Generator				
Instrument	Manufacturer	Type No.	Serial No	Cal. Date
CDN	Schaffner	CAL U100A	20405	N/A
CDN	Schaffner	TRA U150	20454	N/A
CDN M016S	Schaffner	CAL U100A	20410	N/A
CDN M016S	Schaffner	TRA U150	21167	N/A
CDN T002	Schaffner	CAL U100	20491	N/A
CDN T002	Schaffner	TRA U150	21169	N/A
CDN T400	Schaffner	CAL U100	17735	N/A
CDN T400	Schaffner	TRA U150	21166	N/A
Coupling Decoupling Network	Schaffner	CDN M016S	20823	2010/04/02
Coupling Decoupling Network	Schaffner	CDN T002	19018	2010/04/02
Coupling Decoupling Network	Schaffner	CDN T400	21226	2010/04/02
EM-CLAMP	Schaffner	KEMZ 801	21024	2010/04/02

# 2.3. Measurement Uncertainty

#### Conducted Emission

The measurement uncertainty is evaluated as  $\pm$  2.26 dB. Impedance Stabilization Network

The measurement uncertainty is evaluated as  $\pm$  2.26 dB.

#### Radiated Emission

The measurement uncertainty is evaluated as  $\pm$  3.19 dB.

## Electrostatic Discharge

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in ESD testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant ESD standards. The immunity test signal from the ESD system meet the required specifications in IEC 61000-4-2 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 1.0 % and 0.1%.

#### Radiated susceptibility

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in RS testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant RS standards. The immunity test signal from the RS system meet the required specifications in IEC 61000-4-3 through the calibration for the uniform field strength and monitoring for the test level with the uncertainty evaluation report for the electrical filed strength as being 3.57 dB. Electrical fast transient/burst

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in EFT/Burst testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant EFT/Burst standards. The immunity test signal from the EFT/Burst system meet the required specifications in IEC 61000-4-4 through the calibration report with the calibrated uncertainty for the waveform of voltage, frequency and timing as being 4 %, and 2.5%.

#### <u>Surge</u>

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in Surge testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant Surge standards. The immunity test signal from the Surge system meet the required specifications in IEC 61000-4-5 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 3.5 % and 0.1%.

### Conducted susceptibility

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in CS testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant CS standards. The immunity test signal from the CS system meet the required specifications in IEC 61000-4-6 through the calibration for unmodulated signal and monitoring for the test level with the uncertainty evaluation report for the injected modulated signal level through CDN and EM Clamp/Direct Injection as being 2.0 dB and 2.61 dB.

### Power frequency magnetic field

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in PFM testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant PFM standards. The immunity test signal from the PFM system meet the required specifications in IEC 61000-4-8 through the calibration report with the calibrated uncertainty for the Gauss Meter to verify the output level of magnetic field strength as being 2.0 %.

### Voltage dips and interruption

As what is concluded in the document from Note2 of clause 5.4.6.2 of ISO/IEC 17025: 1999[2], the requirements for measurement uncertainty in DIP testing are deemed to have been satisfied, and the testing is reported in accordance with the relevant DIP standards. The immunity test signal from the DIP system meet the required specifications in IEC 61000-4-11 through the calibration report with the calibrated uncertainty for the waveform of voltage and timing as being 3.5 % and 0.1%.

# 2.4. Test Environment

Performed Item	Items	Required	Actual
	Temperature (°C)	15-35	25
Conducted Emission	Humidity (%RH)	25-75	50
	Barometric pressure (mbar)	860-1060	950-1000
	Temperature (°C)	15-35	25
Impedance Stabilization Network	Humidity (%RH)	25-75	50
	Barometric pressure (mbar)	860-1060	950-1000
	Temperature (°C)	15-35	25
Radiated Emission	Humidity (%RH)	25-75	50
	Barometric pressure (mbar)	860-1060	950-1000
	Temperature (°C)	15-35	19
Electrostatic Discharge	Humidity (%RH)	30-60	43
	Barometric pressure (mbar)	860-1060	950-1000
	Temperature (°C)	15-35	20
Radiated susceptibility	Humidity (%RH)	25-75	46
	Barometric pressure (mbar)	860-1060	950-1000
	Temperature (°C)	15-35	19
Electrical fast transient/burst	Humidity (%RH)	25-75	43
	Barometric pressure (mbar)	860-1060	950-1000
	Temperature (°C)	15-35	19
Surge	Humidity (%RH)	10-75	43
	Barometric pressure (mbar)	860-1060	950-1000
	Temperature (°C)	15-35	19
Conducted susceptibility	Humidity (%RH)	25-75	52
	Barometric pressure (mbar)	860-1060	950-1000
	Temperature (°C)	15-35	19
Power frequency magnetic field	Humidity (%RH)	25-75	42
	Barometric pressure (mbar)	860-1060	950-1000
	Temperature (°C)	15-35	19
Voltage dips and interruption	Humidity (%RH)	25-75	42
	Barometric pressure (mbar)	860-1060	950-1000

### 3. Conducted Emission (Main Terminals)

### 3.1. Test Specification

According to EMC Standard : EN 55022 and AS/NZS CISPR 22

#### 3.2. Test Setup



#### 3.3. Limit

Limits				
Frequency (MHz)	QP (dBuV)	AV (dBuV)		
0.15 - 0.50	79	66		
0.50-5.0	73	60		
5.0 - 30	73	60		

Remarks: In the above table, the tighter limit applies at the band edges.

## 3.4. Test Procedure

The EUT and simulators are connected to the main power through a line impedance stabilization network (L.I.S.N.). This provides a 50 ohm /50uH coupling impedance for the measuring equipment. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination. (Please refers to the block diagram of the test setup and photographs.) Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed on conducted measurement.

Conducted emissions were invested over the frequency range from 0.15MHz to 30MHz using a receiver bandwidth of 9kHz.

### 3.5. Deviation from Test Standard

No deviation.

## 3.6. Test Result

Site : SR_1	Time : 2011/03/11 - 23:44	
Limit : CISPR_A_00M_QP	Margin : 10	
EUT : Network Camera	Probe : ENV_216_L1 - Line1	
Power : AC 230V/50Hz	Note : Mode 1	





Site : SR_1	Time : 2011/03/11 - 23:45
Limit : CISPR_A_00M_QP	Margin : 0
EUT : Network Camera	Probe : ENV_216_L1 - Line1
Power : AC 230V/50Hz	Note : Mode 1



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV)	(dB)	(dBuV)	
1	*	0.173	9.790	31.990	41.780	-37.220	79.000	QUASIPEAK
2		0.236	9.790	13.890	23.680	-55.320	79.000	QUASIPEAK
3		0.306	9.790	11.830	21.620	-57.380	79.000	QUASIPEAK
4		0.627	9.790	18.530	28.320	-44.680	73.000	QUASIPEAK
5		11.466	9.919	11.850	21.769	-51.231	73.000	QUASIPEAK
6		19.775	10.110	17.710	27.820	-45.180	73.000	QUASIPEAK

- 1. All Reading Levels are Quasi-Peak and average value.
- 2. "  $^{\ast}$  ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor



Site : SR_1	Time : 2011/03/11 - 23:45	
Limit : CISPR_A_00M_AV	Margin : 0	
EUT : Network Camera	Probe : ENV_216_L1 - Line1	
Power : AC 230V/50Hz	Note : Mode 1	



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV)	(dB)	(dBuV)	
1		0.173	9.790	21.360	31.150	-34.850	66.000	AVERAGE
2		0.236	9.790	5.100	14.890	-51.110	66.000	AVERAGE
3		0.306	9.790	5.050	14.840	-51.160	66.000	AVERAGE
4	*	0.627	9.790	15.690	25.480	-34.520	60.000	AVERAGE
5		11.466	9.919	6.550	16.469	-43.531	60.000	AVERAGE
6		19.775	10.110	8.940	19.050	-40.950	60.000	AVERAGE

- 1. All Reading Levels are Quasi-Peak and average value.
- 2. "  $^{\ast}$  ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor



Site : SR_1	Time : 2011/03/11 - 23:46	
Limit : CISPR_A_00M_QP	Margin : 10	
EUT : Network Camera	Probe : ENV_216_N - Line2	
Power : AC 230V/50Hz	Note : Mode 1	





Site : SR_1	Time : 2011/03/11 - 23:47
Limit : CISPR_A_00M_QP	Margin : 0
EUT : Network Camera	Probe : ENV_216_N - Line2
Power : AC 230V/50Hz	Note : Mode 1



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV)	(dB)	(dBuV)	
1	*	0.177	9.780	27.490	37.270	-41.730	79.000	QUASIPEAK
2		0.240	9.780	24.830	34.610	-44.390	79.000	QUASIPEAK
3		0.310	9.790	19.570	29.360	-49.640	79.000	QUASIPEAK
4		0.627	9.790	16.790	26.580	-46.420	73.000	QUASIPEAK
5		6.451	9.850	13.350	23.200	-49.800	73.000	QUASIPEAK
6		19.591	10.229	20.390	30.619	-42.381	73.000	QUASIPEAK

- 1. All Reading Levels are Quasi-Peak and average value.
- 2. "  $^{\ast}$  ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor



Site : SR_1	Time : 2011/03/11 - 23:47
Limit : CISPR_A_00M_AV	Margin : 0
EUT : Network Camera	Probe : ENV_216_N - Line2
Power : AC 230V/50Hz	Note : Mode 1



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV)	(dB)	(dBuV)	
1		0.177	9.780	16.530	26.310	-39.690	66.000	AVERAGE
2		0.240	9.780	13.960	23.740	-42.260	66.000	AVERAGE
3		0.310	9.790	10.970	20.760	-45.240	66.000	AVERAGE
4		0.627	9.790	10.770	20.560	-39.440	60.000	AVERAGE
5		6.451	9.850	6.210	16.060	-43.940	60.000	AVERAGE
6	*	19.591	10.229	12.740	22.969	-37.031	60.000	AVERAGE

- 1. All Reading Levels are Quasi-Peak and average value.
- 2. "  $^{\ast}$  ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor

# 3.7. Test Photograph

Test Mode: Mode 1: Normal OperationDescription: Front View of Conducted Test



Test Mode : Mode 1: Normal Operation Description : Back View of Conducted Test



# 4. Conducted Emissions (Telecommunication Ports)

# 4.1. Test Specification

According to EMC Standard : EN 55022 and AS/NZS CISPR 22

# 4.2. Test Setup



# 4.3. Limit

Limits					
Frequency (MHz)	QP (dBuV)	AV (dBuV)			
0.15 - 0.50	97 – 87	84 – 74			
0.50 - 30	87	74			

Remarks:

The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz~0.50 MHz.



#### 4.4. Test Procedure

#### **Telecommunication Port:**

The mains voltage shall be supplied to the EUT via the LISN when the measurement of telecommunication port is performed. The common mode disturbances at the telecommunication port shall be connected to the ISN, which is 150 ohm impedance. Both alternative cables are tested related to the LCL requested. The measurement range is from 150kHz to 30MHz. The bandwidth of measurement is set to 9kHz. The 75dB LCL ISN is used for cat. 6 cable, the 65dB LCL ISN is used for cat. 5 cable, 55dB LCL ISN is used for cat. 3.

#### 4.5. Deviation from Test Standard

No deviation.

#### 4.6. Test Result

Site : SR_1	Time : 2011/03/11 - 23:58
Limit : ISN_Voltage_A_00M_QP	Margin : 10
EUT : Network Camera	Probe : ISN_T4 - Line1
Power : AC 230V/50Hz	Note : Mode 1: ISN 10MB





Site : SR_1	Time : 2011/03/11 - 23:59		
Limit : ISN_Voltage_A_00M_QP	Margin : 0		
EUT : Network Camera	Probe : ISN_T4 - Line1		
Power : AC 230V/50Hz	Note : Mode 1: ISN 10MB		



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV)	(dB)	(dBuV)	
1		3.752	9.990	41.050	51.040	-35.960	87.000	QUASIPEAK
2		6.252	9.976	43.670	53.646	-33.354	87.000	QUASIPEAK
3	*	7.502	9.970	48.930	58.900	-28.100	87.000	QUASIPEAK
4		8.752	9.968	44.610	54.578	-32.422	87.000	QUASIPEAK
5		11.252	9.960	43.290	53.250	-33.750	87.000	QUASIPEAK
6		12.502	10.073	46.550	56.623	-30.377	87.000	QUASIPEAK

- 1. All Reading Levels are Quasi-Peak and average value.
- 2. "  $^{\ast}$  ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor



Site : SR_1	Time : 2011/03/11 - 23:59		
Limit : ISN_Voltage_A_00M_AV	Margin : 0		
EUT : Network Camera	Probe : ISN_T4 - Line1		
Power : AC 230V/50Hz	Note : Mode 1: ISN 10MB		



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV)	(dB)	(dBuV)	
1		3.752	9.990	27.620	37.610	-36.390	74.000	AVERAGE
2		6.252	9.976	32.700	42.676	-31.324	74.000	AVERAGE
3	*	7.502	9.970	36.480	46.450	-27.550	74.000	AVERAGE
4		8.752	9.968	32.300	42.268	-31.732	74.000	AVERAGE
5		11.252	9.960	31.500	41.460	-32.540	74.000	AVERAGE
6		12.502	10.073	34.530	44.603	-29.397	74.000	AVERAGE

- 1. All Reading Levels are Quasi-Peak and average value.
- 2. " \* ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor



Site : SR_1	Time : 2011/03/11 - 23:50		
Limit : ISN_Voltage_A_00M_QP	Margin : 10		
EUT : Network Camera	Probe : ISN_T4 - Line1		
Power : AC 230V/50Hz	Note : Mode 1: ISN 100MB		




Site : SR_1	Time : 2011/03/11 - 23:51
Limit : ISN_Voltage_A_00M_QP	Margin : 0
EUT : Network Camera	Probe : ISN_T4 - Line1
Power : AC 230V/50Hz	Note : Mode 1: ISN 100MB



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV)	(dB)	(dBuV)	
1		3.037	9.990	34.530	44.520	-42.480	87.000	QUASIPEAK
2		5.236	9.980	41.330	51.310	-35.690	87.000	QUASIPEAK
3		10.244	9.960	43.430	53.390	-33.610	87.000	QUASIPEAK
4		12.748	10.095	44.810	54.905	-32.095	87.000	QUASIPEAK
5	*	16.228	10.130	45.530	55.660	-31.340	87.000	QUASIPEAK
6		23.130	10.100	45.530	55.630	-31.370	87.000	QUASIPEAK

- 1. All Reading Levels are Quasi-Peak and average value.
- 2. "  $^{\ast}$  ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor



Site : SR_1	Time : 2011/03/11 - 23:51
Limit : ISN_Voltage_A_00M_AV	Margin : 0
EUT : Network Camera	Probe : ISN_T4 - Line1
Power : AC 230V/50Hz	Note : Mode 1: ISN 100MB



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV)	(dB)	(dBuV)	
1		3.037	9.990	34.520	44.510	-29.490	74.000	AVERAGE
2		5.236	9.980	37.600	47.580	-26.420	74.000	AVERAGE
3		10.244	9.960	40.820	50.780	-23.220	74.000	AVERAGE
4		12.748	10.095	42.160	52.255	-21.745	74.000	AVERAGE
5		16.228	10.130	43.000	53.130	-20.870	74.000	AVERAGE
6	*	23.130	10.100	43.240	53.340	-20.660	74.000	AVERAGE

- 1. All Reading Levels are Quasi-Peak and average value.
- 2. " \* ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor

## 4.7. Test Photograph

Test Mode : Mode 1: Normal Operation Description : Front View of ISN Test



Test Mode : Mode 1: Normal Operation Description : Back View of ISN Test



### 5. Radiated Emission

### 5.1. Test Specification

According to EMC Standard : EN 55022 and AS/NZS CISPR 22

### 5.2. Test Setup

Under 1GHz Test Setup:



Above 1GHz Test Setup:



## 5.3. Limit

Limits					
Frequency MHz	Distance (m)	dBuV/m			
30 – 230	10	40			
230 – 1000	10	47			

Limits						
Frequency (GHz)	Distance (m)	Peak (dBuV/m)	Average (dBuV/m)			
1 – 3	3	76	56			
3 – 6	3	80	60			

Remark:

- 1. The tighter limit shall apply at the edge between two frequency bands.
- 2. Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the device or system.

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 108	1000
108 – 500	2000
500 – 1000	5000
Above 1000	5 <sup>th</sup> harmonic of the highest frequency or 6 GHz, whichever is lower

### 5.4. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT was positioned such that the distance from antenna to the EUT was 3/10 meters. The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level.

Both horizontal and vertical polarization of the antenna are set on measurement. In order to find the maximum emission, all of the interface cables must be manipulated on radiated measurement.

Radiated emissions were invested over the frequency range from 30MHz to1GHz using a receiver bandwidth of 120kHz and above 1GHz using a receiver bandwidth of 1MHz. 30MHz to1GHz Radiated was performed at an antenna to EUT distance of 10 meters. Above1GHz Radiated was performed at an antenna to EUT distance of 3 meters. It is placed with absorb on the ground between EUT and Antenna.

### 5.5. Deviation from Test Standard

### 5.6. Test Result

Site : OATS-3	Time : 2011/03/09 - 11:32
Limit : CISPR_A_10M_QP	Margin : 6
EUT : Network Camera	Probe : Site3_CBL6112_10M_0811 - HORIZONTAL
Power : AC 230V/50Hz	Note : Mode 1



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV/m)	(dB)	(dBuV/m)	
1	*	125.000	15.012	9.714	24.726	-15.274	40.000	QUASIPEAK
2		162.000	13.128	10.567	23.695	-16.305	40.000	QUASIPEAK
3		250.024	16.299	10.495	26.795	-20.205	47.000	QUASIPEAK
4		356.401	18.915	6.900	25.815	-21.185	47.000	QUASIPEAK
5		425.632	20.587	7.020	27.607	-19.393	47.000	QUASIPEAK
6		725.026	25.240	3.139	28.379	-18.621	47.000	QUASIPEAK

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. " \* ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor



Site : OATS-3	Time : 2011/03/09 - 11:56
Limit : CISPR_A_10M_QP	Margin : 6
EUT : Network Camera	Probe : Site3_CBL6112_10M_0811 - VERTICAL
Power : AC 230V/50Hz	Note : Mode 1



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV/m)	(dB)	(dBuV/m)	
1	*	72.600	9.323	23.958	33.282	-6.718	40.000	QUASIPEAK
2		125.000	15.012	17.467	32.479	-7.521	40.000	QUASIPEAK
3		162.000	13.128	17.010	30.138	-9.862	40.000	QUASIPEAK
4		250.013	16.299	10.717	27.016	-19.984	47.000	QUASIPEAK
5		324.007	18.043	6.400	24.443	-22.557	47.000	QUASIPEAK
6		510.758	22.252	10.308	32.561	-14.439	47.000	QUASIPEAK
7		652.630	24.359	4.551	28.910	-18.090	47.000	QUASIPEAK
8		815.784	26.531	3.890	30.421	-16.579	47.000	QUASIPEAK

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. " \* ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor



Site : 9x6x6_Chamber	Time : 2011/03/17 - 16:08		
Limit : CISPR_22_A_(Above_1G)_03M_PK	Margin : 6		
EUT : Network Camera	Probe : 9120D_1-18G_Horn - HORIZONTAL		
Power : AC 230V/50Hz	Note : Mode 1		



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV/m)	(dB)	(dBuV/m)	
1	*	1125.000	-8.064	48.770	40.706	-35.294	76.000	PEAK
2		1633.000	-6.290	45.650	39.359	-36.641	76.000	PEAK
3		2033.000	-4.459	45.030	40.571	-35.429	76.000	PEAK

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. " \* ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor



Site : 9x6x6_Chamber	Time : 2011/03/17 - 16:08
Limit : CISPR_22_A_(Above_1G)_03M_PK	Margin : 6
EUT : Network Camera	Probe : 9120D_1-18G_Horn - VERTICAL
Power : AC 230V/50Hz	Note : Mode 1



		Frequency	Correct Factor	Reading Level	Measure Level	Margin	Limit	Detector Type
		(MHz)	(dB)	(dBuV)	(dBuV/m)	(dB)	(dBuV/m)	
1		1333.000	-7.587	48.700	41.113	-34.887	76.000	PEAK
2	*	3000.000	-2.797	50.370	47.574	-28.426	76.000	PEAK

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. " \* ", means this data is the worst emission level.
- 3. Measurement Level = Reading Level + Correct Factor

## 5.7. Test Photograph

Test Mode : Mode 1: Normal Operation Description : Front View of Radiated Test



Test Mode : Mode 1: Normal Operation Description : Back View of Radiated Test





Test Mode	: Mode 1: Normal Operation
Description	: Front View of High Frequency Radiated Test



### 6. Harmonic Current Emission

### 6.1. Test Specification

According to EMC Standard : EN 61000-3-2

### 6.2. Test Setup



### 6.3. Limit

(a) Limits of Class A Harmonics Currents

Harmonics	Maximum Permissible	Harmonics	Maximum Permissible	
Order	harmonic current	Order	harmonic current	
n	А	n	А	
Od	ld harmonics	Even harmonics		
3	2.30	2	1.08	
5	1.14	4	0.43	
7	0.77	6	0.30	
9	0.40	$8 \le n \le 40$	0.23 * 8/n	
11	0.33			
13	0.21			
$15 \le n \le 39$	0.15 * 15/n			



(b) Limits of Class B Harmonics Currents

For Class B equipment, the harmonic of the input current shall not exceed the maximum permissible values given in table that is the limit of Class A multiplied by a factor of 1.5.

(C)	Limits	of Class	C Ha	rmonics	Currents
-----	--------	----------	------	---------	----------

Harmonics Order	Maximum Permissible harmonic current Expressed as a percentage of the input current at the fundamental frequency
n	%
2	2
3	<b>30</b> · λ*
5	10
7	7
9	5
$11 \le n \le 39$	3
(odd harmonics only)	3
$*\lambda$ is the circuit power factor	

(d) Limits of Class D Harmonics Currents

Harmonics Order	Maximum Permissible	Maximum Permissible	
	harmonic current per watt	harmonic current	
n	mA/W	А	
3	3.4	2.30	
5	1.9	1.14	
7	1.0	0.77	
9	0.5	0.40	
11	0.35	0.33	
11 ≤ n ≤ 39	3.85/n	See limit of Class A	
(odd harmonics only)	5.00/11	See mind of Class A	



### 6.4. Test Procedure

The EUT is supplied in series with power analyzer from a power source having the same normal voltage and frequency as the rated supply voltage and the equipment under test. And the rated voltage at the supply voltage of EUT of 0.94 times and 1.06 times shall be performed.

### 6.5. Deviation from Test Standard



### 6.6. Test Result

Product	Network Camera				
Test Item	Power Harmonics				
Test Mode	Mode 1: Normal Operation				
Date of Test	2011/03/15	Test Site	No.3 Shielded Room		

Test Result: Pass

Source qualification: Normal

Current & voltage waveforms



Harmonics and Class A limit line

European Limits





Test Re	sult: Pass	Source	qualification	n: Normal				
THC(A)	: 0.11 I-T	HD(%): 223	.33	POHC(A):	0.03	8	POHC Limit(A	): 0.251
Highest	parameter valu	es during tes	st:					
	V_RMS (Volts):	229.65		Frequency(	Hz):	50.00		
	I_Peak (Amps):	0.876		I_RMS (Am	ps):	0.171		
	I Fund (Amps):	0.050		Crest Facto	r:	5.330		
	Power (Watts):	11.3		Power Factor	or:	0.288		
Harm#	Harms(avg)	100%Limit	%of Limit	Harms(ma	ax)	150%Limit	t %of Limit	Status
2	0.003	1.080	0.3	0.0	04	1.620	0.22	Pass
3	0.041	2.300	1.8	0.0	43	3.450	) 1.25	Pass
4	0.003	0.430	0.7	0.0	04	0.645	<b>0.56</b>	Pass
5	0.040	1.140	3.5	0.0	42	1.710	) 2.45	Pass
6	0.003	0.300	1.0	0.0	03	0.450	0.76	Pass
7	0.038	0.770	5.0	0.0	40	1.155	5 3.47	Pass
8	0.003	0.230	1.2	0.0	03	0.345	<b>0.99</b>	Pass
9	0.036	0.400	9.0	0.0	38	0.600	) 6.35	Pass
10	0.003	0.184	1.5	0.0	03	0.276	<b>5</b> 1.19	Pass
11	0.034	0.330	10.2	0.0	36	0.495	5 7.19	Pass
12	0.003	0.153	1.7	0.0	03	0.230	) 1.37	Pass
13	0.031	0.210	14.8	0.0	33	0.315	5 10.39	Pass
14	0.002	0.131	1.9	0.0	03	0.197	' 1.52	Pass
15	0.028	0.150	18.9	0.0	30	0.225	5 13.25	Pass
16	0.002	0.115	2.0	0.0	03	0.173	3 1.62	Pass
17	0.025	0.132	19.3	0.0	27	0.199	) 13.46	Pass
18	0.002	0.102	2.1	0.0	03	0.153	3 1.69	Pass
19	0.023	0.118	19.1	0.0	24	0.178	3 13.35	Pass
20	0.002	0.092	2.2	0.0	02	0.138	3 1.75	Pass
21	0.020	0.107	18.5	0.0	21	0.161	12.92	Pass
22	0.002	0.084	2.2	0.0	02	0.125	5 1.77	Pass
23	0.017	0.098	17.6	0.0	18	0.147	' 12.30	Pass
24	0.002	0.077	2.1	0.0	02	0.115	5 1.74	Pass
25	0.015	0.090	16.4	0.0	15	0.135	5 11.45	Pass
26	0.001	0.071	2.0	0.0	02	0.106	3 1.70	Pass
27	0.013	0.083	15.1	0.0	13	0.125	5 10.58	Pass
28	0.001	0.066	1.9	0.0	02	0.099	) 1.64	Pass
29	0.011	0.078	13.7	0.0	11	0.116	9.60	Pass
30	0.001	0.061	1.8	0.0	01	0.092	2 1.58	Pass
31	0.009	0.073	12.4	0.0	09	0.109	8.65	Pass
32	0.001	0.058	1.7	0.0	01	0.086	3 1.45	Pass
33	0.008	0.068	11.2	0.0	08	0.102	2 7.80	Pass
34	0.001	0 054	1.5	0.0	01	0.081	1 34	Pass
35	0.006	0.064	10.1	0.0	07	0.096	3 7 00	Pass
36	0.001	0.051	14	0.0	01	0.077	′ 1 <i>2</i> 4	Pass
37	0.005	0.061	9.0	0.0	06	0.091	6.21	Pass
38	0 001	0.048	12	0.0	01	0.073	3 1 13	Pass
39	0.005	0.058	82	0.0	05	0.087	′ <u>5</u> 56	Pass
40	0.001	0.046	1.1	0.0	01	0.069	) 1.01	Pass

1.Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.

2:According to EN61000-3-2 paragraph 7 the note 1 and 2 are valid for all applications having an active input power >75W. Others the result should be pass.

## 6.7. Test Photograph

Test Mode : Mode 1: Normal Operation Description : Power Harmonics Test Setup



### 7. Voltage Fluctuation and Flicker

### 7.1. Test Specification

According to EMC Standard : EN 61000-3-3

### 7.2. Test Setup



### 7.3. Limit

The following limits apply:

- the value of P<sub>st</sub> shall not be greater than 1.0;
- the value of P<sub>lt</sub> shall not be greater than 0.65;
- $-\,$  the value of d(t) during a voltage change shall not exceed 3.3  $\,\%\,$  for more than 500 ms;
- $-\,$  the relative steady-state voltage change, dc, shall not exceed 3.3  $\,\%;$
- the maximum relative voltage change, d<sub>max</sub>, shall not exceed;
- a) 4 % without additional conditions;
- b) 6 % for equipment which is:
  - switched manually, or
  - switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption.

NOTE The cycling frequency will be further limited by the  $P_{st}$  and  $P_{1t}$  limit.

For example: a  $d_{max}$  of 6% producing a rectangular voltage change characteristic twice per hour will give a  $P_{1t}$  of about 0.65.



- attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or
- switched on automatically, or is intended to be switched on manually, no more than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.

P<sub>st</sub> and P<sub>1t</sub> requirements shall not be applied to voltage changes caused by manual switching.

### 7.4. Test Procedure

ӘџіеТек

The EUT is supplied in series with power analyzer from a power source having the same normal voltage and frequency as the rated supply voltage and the equipment under test. And the rated voltage at the supply voltage of EUT of 0.94 times and 1.06 times shall be performed.

### 7.5. Deviation from Test Standard



## 7.6. Test Result

Product	Network Camera				
Test Item	Voltage Fluctuation and Flicker				
Test Mode	Mode 1: Normal Operation				
Date of Test	2011/03/15 Test Site No.3 Shielded Room				

Test Result: Pass

Status: Test Completed

### Psti and limit line

European Limits



### Plt and limit line



Parameter values recorded during the test:				
Vrms at the end of test (Volt):	229.57			
Highest dt (%):	0.00			
Time(mS) > dt:	0.0			
Highest dc (%):	0.00			
Highest dmax (%):	0.00			
Highest Pst (10 min. period):	0.064			
Highest Plt (2 hr. period):	0.028			

Test limit (%):	3.30	Pass
Test limit (mS):	500.0	Pass
Test limit (%):	3.30	Pass
Test limit (%):	4.00	Pass
Test limit:	1.000	Pass
Test limit:	0.650	Pass

## 7.7. Test Photograph

Test Mode : Mode 1: Normal Operation Description : Flicker Test Setup



### 8. Electrostatic Discharge

### 8.1. Test Specification

According to Standard : IEC 61000-4-2

### 8.2. Test Setup



### 8.3. Limit

Item	Environmental	Units	Test Specification	Performance
	Phenomena			Criteria
Enclo	osure Port			
	Electrostatic Discharge	kV(Charge Voltage)	±8 Air Discharge	D
			±4 Contact Discharge	В

## 8.4. Test Procedure

Direct application of discharges to the EUT:

Contact discharge was applied only to conductive surfaces of the EUT. Air discharges were applied only to non-conductive surfaces of the EUT. During the test, it was performed with single discharges. For the single discharge time between successive single discharges will be keep longer 1 second. It was at least ten single discharges with positive and negative at the same selected point. The selected point, which was performed with electrostatic discharge, was marked on the red label of the EUT.

Indirect application of discharges to the EUT:

Vertical Coupling Plane (VCP):

The coupling plane, of dimensions  $0.5m \times 0.5m$ , is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge. It was at least ten single discharges with positive and negative at the same selected point. Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge. It was at least ten single discharges with positive and negative at the same selected point.

## 8.5. Deviation from Test Standard

### 8.6. Test Result

Product	Network Camera			
Test Item	Electrostatic Discharge			
Test Mode	Mode 1: Normal Operation			
Date of Test	2011/03/16	Test Site	No.6 Shielded Room	

Item	Amount of Discharge	Voltage	Required Criteria	Complied To Criteria (A,B,C)	Results
	10	+8kV	В	А	Pass
Air Discharge	10	-8kV	В	А	Pass
Contact Discharge	25	+4kV	В	А	Pass
Contact Discharge	25	-4kV	В	А	Pass
Indirect Discharge	25	+4kV	В	А	Pass
(HCP)	25	-4kV	В	А	Pass
Indirect Discharge	25	+4kV	В	А	Pass
(VCP Front)	25	-4kV	В	А	Pass
Indirect Discharge	25	+4kV	В	А	Pass
(VCP Left)	25	-4kV	В	А	Pass
Indirect Discharge	25	+4kV	В	А	Pass
(VCP Back)	25	-4kV	В	А	Pass
Indirect Discharge	25	+4kV	В	А	Pass
(VCP Right)	25	-4kV	В	А	Pass

### Note:

The testing performed is from lowest level up to the highest level as required by standard, but only highest level is shown on the report.

NR: No Requirement

- $\boxtimes\;$  Meet criteria A: Operate as intended during and after the test
- $\hfill\square$  Meet criteria B: Operate as intended after the test
- □ Meet criteria C: Loss/Error of function
- □ Additional Information
  - $\Box$  EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at \_\_\_\_\_ kV.
  - $\boxtimes$  No false alarms or other malfunctions were observed during or after the test.

### Remark:

The Contact discharges were applied at least total 200 discharges at a minimum of four test points.

## 8.7. Test Photograph

Test Mode : Mode 1: Normal Operation Description : ESD Test Setup



### 9. Radiated Susceptibility

### 9.1. Test Specification

According to Standard : IEC 61000-4-3

### 9.2. Test Setup



### 9.3. Limit

Item	Environmental	Units	Test	Performance
	Phenomena		Specification	Criteria
Enclo	osure Port			
	Radio-Frequency	MHz	80-1000	
	Electromagnetic Field	V/m(Un-modulated, rms)	3	А
	Amplitude Modulated	% AM (1kHz)	80	

### 9.4. Test Procedure

QuieTek

The EUT and load, which are placed on a table that is 0.8 meter above ground, are placed with one coincident with the calibration plane such that the distance from antenna to the EUT was 3 meters.

Both horizontal and vertical polarization of the antenna and four sides of the EUT are set on measurement.

In order to judge the EUT performance, a CCD camera is used to monitor EUT screen.

All the scanning conditions are as follows:

	Condition of Test	Remarks
1.	Field Strength	3 V/m Level 2
2.	Radiated Signal	AM 80% Modulated with 1kHz
3.	Scanning Frequency	80MHz - 1000MHz
4	Dwell Time	3 Seconds
5.	Frequency step size $\Delta f$ :	1%
6.	The rate of Swept of Frequency	1.5 x 10 <sup>-3</sup> decades/s

### 9.5. Deviation from Test Standard

### 9.6. Test Result

Product	Network Camera		
Test Item	Radiated susceptibility		
Test Mode	Mode 1: Normal Operation		
Date of Test	2011/03/16	Test Site	Chamber5

Frequency (MHz)	Position (Angle)	Polarity (H or V)	Field Strength (V/m)	Required Criteria	Complied To Criteria (A, B, C)	Results
80-1000	FRONT	Н	3	А	А	PASS
80-1000	FRONT	V	3	А	А	PASS
80-1000	BACK	Н	3	А	А	PASS
80-1000	BACK	V	3	А	А	PASS
80-1000	RIGHT	Н	3	А	А	PASS
80-1000	RIGHT	V	3	А	А	PASS
80-1000	LEFT	Н	3	А	А	PASS
80-1000	LEFT	V	3	А	А	PASS
80-1000	UP	Н	3	А	А	PASS
80-1000	UP	V	3	А	А	PASS
80-1000	DOWN	Н	3	А	А	PASS
80-1000	DOWN	V	3	А	А	PASS

Note:

The testing performed is from lowest level up to the highest level as required by standard, but only highest level is shown on the report.

- $\boxtimes\,$  Meet criteria A: Operate as intended during and after the test
- $\hfill\square$  Meet criteria B: Operate as intended after the test
- □ Meet criteria C: Loss/Error of function
- □ Additional Information
  - $\hfill\square$  There was no observable degradation in performance.
  - EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at \_\_\_\_\_ V/m at frequency \_\_\_\_\_MHz.
- $\boxtimes$  No false alarms or other malfunctions were observed during or after the test.

## 9.7. Test Photograph

Test Mode: Mode 1: Normal OperationDescription: Radiated Susceptibility Test Setup



### **10. Electrical Fast Transient/Burst**

### **10.1. Test Specification**

According to Standard : IEC 61000-4-4

### 10.2. Test Setup



### 10.3. Limit

Item Environmental Phenomena	Units	Test Specification	Performance Criteria
I/O and communication ports			
Fast Transients Common	kV (Peak)	<u>+</u> 0.5	
Mode	Tr/Th ns	5/50	В
	Rep. Frequency kHz	5	
Input DC Power Ports			
Fast Transients Common	kV (Peak)	<u>+</u> 0.5	
Mode	Tr/Th ns	5/50	В
	Rep. Frequency kHz	5	
Input AC Power Ports			
Fast Transients Common	kV (Peak)	<u>+</u> 1	
Mode	Tr/Th ns	5/50	В
	Rep. Frequency kHz	5	

### 10.4. Test Procedure

The EUT is placed on a table that is 0.8 meter height. A ground reference plane is placed on the table, and uses a 0.1m insulation between the EUT and ground reference plane. The minimum area of the ground reference plane is 1m\*1m, and 0.65mm thick min, and projected beyond the EUT by at least 0.1m on all sides.

Test on I/O and communication ports:

The EFT interference signal is through a coupling clamp device couples to the signal and control lines of the EUT with burst noise for 1minute.

Test on power supply ports:

The EUT is connected to the power mains through a coupling device that directly couples the EFT/B interference signal.

Each of the Line and Neutral conductors is impressed with burst noise for 1 minute.

The length of the signal and power lines between the coupling device and the EUT is 0.5m.

### 10.5. Deviation from Test Standard



### 10.6. Test Result

Product	Network Camera		
Test Item	Electrical fast transient/burst		
Test Mode	Mode 1: Normal Operation		
Date of Test	2011/03/16	Test Site	No.3 Shielded Room

Inject Line	Polarity	Voltage kV	Inject Time (Second)	Inject Method	Required Criteria	Complied to Criteria	Result
L+N+PE	±	1kV	60	Direct	В	А	PASS
LAN	±	0.5kV	60	Clamp	В	A	PASS

Note:

The testing performed is from lowest level up to the highest level as required by standard, but only highest level is shown on the report.

- Meet criteria A : Operate as intended during and after the test
- ☐ Meet criteria B : Operate as intended after the test
- ☐ Meet criteria C : Loss/Error of function
- □ Additional Information
  - EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at \_\_\_\_\_ kV of Line \_\_\_\_\_.
- $\boxtimes$  No false alarms or other malfunctions were observed during or after the test.

## 10.7. Test Photograph

Test Mode : Mode 1: Normal Operation Description : EFT/B Test Setup



Test Mode : Mode 1: Normal Operation Description : EFT/B Test Setup-Clamp





## 11. Surge

### 11.1. Test Specification

According to Standard : IEC 61000-4-5

### 11.2. Test Setup



### 11.3. Limit

Item	Environmental Phenomena	Units	Test Specification	Performance Criteria	
Signal Ports and Telecommunication Ports(See 1) and 2) )					
5	Surges	Tr/Th us	1.2/50 (8/20)	р	
L	ine to Ground	kV	± 1	D	
Input	DC Power Ports				
5	Surges	Tr/Th us	1.2/50 (8/20)	р	
L	ine to Ground	kV	± 0.5	D	
AC In	put and AC Output Power P	orts			
5	Surges	Tr/Th us	1.2/50 (8/20)		
L	ine to Line	kV	± 1	В	
L	ine to Ground	kV	± 2		

- 1) Applicable only to ports which according to the manufacturer's may directly to outdoor cables.
- 2) Where normal functioning cannot be achieved because of the impact of the CDN on the EUT, no immunity test shall be required.

### 11.4. Test Procedure

The EUT and its load are placed on a table that is 0.8 meter above a metal ground plane measured 1m\*1m min. and 0.65mm thick min. And projected beyond the EUT by at least 0.1m on all sides. The length of power cord between the coupling device and the EUT shall be 2m or less.

For Input and Output AC Power or DC Input and DC Output Power Ports:

The EUT is connected to the power mains through a coupling device that directly couples the Surge interference signal.

The surge noise shall be applied synchronized to the voltage phase at  $0^0$ ,  $90^0$ ,  $180^0$ ,  $270^0$  and the peak value of the a.c. voltage wave. (Positive and negative)

Each of Line-Earth and Line-Line is impressed with a sequence of five surge voltages with interval of 1 min.

### 11.5. Deviation from Test Standard
Product	Network Camera		
Test Item	Surge		
Test Mode	Mode 1: Normal Operation		
Date of Test	2011/03/16	Test Site	No.3 Shielded Room

Iniect			Voltage	Time	Iniect	Required	Complied	
Line	Polarity	Angle		Interval	Method	Criteria	to	Result
LINC			kV	(Second)	Method	Onteria	Criteria	
L-N	±	0	1kV	60	Direct	В	А	PASS
L-N	±	90	1kV	60	Direct	В	A	PASS
L-N	±	180	1kV	60	Direct	В	А	PASS
L-N	±	270	1kV	60	Direct	В	A	PASS
L-PE	±	0	2kV	60	Direct	В	А	PASS
L-PE	±	90	2kV	60	Direct	В	А	PASS
L-PE	±	180	2kV	60	Direct	В	А	PASS
L-PE	±	270	2kV	60	Direct	В	А	PASS
N-PE	±	0	2kV	60	Direct	В	А	PASS
N-PE	±	90	2kV	60	Direct	В	А	PASS
N-PE	±	180	2kV	60	Direct	В	A	PASS
N-PE	±	270	2kV	60	Direct	В	A	PASS

Note:

The testing performed is from lowest level up to the highest level as required by standard, but only highest level is shown on the report.

- Meet criteria A : Operate as intended during and after the test
- Meet criteria B : Operate as intended after the test
- ☐ Meet criteria C : Loss/Error of function
- □ Additional Information
  - EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at \_\_\_\_\_ kV of Line \_\_\_\_\_.
- No false alarms or other malfunctions were observed during or after the test.

## 11.7. Test Photograph

Test Mode : Mode 1: Normal Operation Description : SURGE Test Setup





## **12. Conducted Susceptibility**

#### 12.1. Test Specification

According to Standard : IEC 61000-4-6

#### 12.2. Test Setup

#### **CDN Test Mode**



#### EM Clamp Test Mode





### 12.3. Limit

Item	Environmental Phenomena	Units	Test	Performance		
			Specification	Criteria		
Signa	Signal Ports and Telecommunication Ports					
F	Radio-Frequency	MHz	0.15-80			
(	Continuous Conducted	V (rms,	3	۸		
		Un-modulated)	80	A		
		% AM (1kHz)				
Input	DC Power Ports					
F	Radio-Frequency	MHz	0.15-80			
(	Continuous Conducted	V (rms,	3	Λ		
		Un-modulated)	80	A		
		% AM (1kHz)				
Input	AC Power Ports					
F	Radio-Frequency	MHz	0.15-80			
(	Continuous Conducted	V (rms,	3	Λ		
		Un-modulated)	80	A		
		% AM (1kHz)				

#### 12.4. Test Procedure

The EUT are placed on a table that is 0.8 meter height, and a Ground reference plane on the table, EUT are placed upon table and use a 10cm insulation between the EUT and Ground reference plane.

For Signal Ports and Telecommunication Ports

The disturbance signal is through a coupling and decoupling networks (CDN) or EM-clamp device couples to the signal and Telecommunication lines of the EUT. For Input DC and AC Power Ports

The EUT is connected to the power mains through a coupling and decoupling networks for power supply lines. And directly couples the disturbances signal into EUT.

Used CDN-M2 for two wires or CDN-M3 for three wires.

All the scanning conditions are as follows:

- Condition of Test
- 1. Field Strength
- 2. Radiated Signal
- 3. Scanning Frequency
- 4 Dwell Time
- 5. Frequency step size  $\Delta f$ :
- 6. The rate of Swept of Frequency

#### 12.5. Deviation from Test Standard

Remarks 130dBuV(3V) Level 2 AM 80% Modulated with 1kHz 0.15MHz – 80MHz 3 Seconds 1% 1.5 x 10<sup>-3</sup> decades/s

No deviation.



Product	Network Camera		
Test Item	Conducted susceptibility		
Test Mode	Mode 1: Normal Operation		
Date of Test	2011/03/16	Test Site	No.6 Shielded Room

Frequency	Voltage	Inject	Tested Port	Required	Performance	Result
Range	Applied	Method	of	Criteria	Criteria	
(MHz)	dBuV(V)		EUT		Complied To	
0.15~80	130 (3V)	CDN	AC IN	А	А	PASS
0.15~80	130 (3V)	CDN	LAN	А	А	PASS

Note:

The testing performed is from lowest level up to the highest level as required by standard, but only highest level is shown on the report.

- Meet criteria A : Operate as intended during and after the test
- D Meet criteria B : Operate as intended after the test
- ☐ Meet criteria C : Loss/Error of function
- □ Additional Information
  - □ EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at \_\_\_\_\_ dBuV(V) at frequency \_\_\_\_\_MHz.
  - No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.

## 12.7. Test Photograph

Test Mode : Mode 1: Normal Operation

Description : Conducted Susceptibility Test Setup



Test Mode: Mode 1: Normal OperationDescription: Conducted Susceptibility Test Setup-CDN



### 13. Power Frequency Magnetic Field

#### 13.1. Test Specification

According to Standard : IEC 61000-4-8

#### 13.2. Test Setup



#### 13.3. Limit

Item	Environmental Phenomena	Units	Test Specification	Performance Criteria
Enclosu	re Port			
	Power-Frequency	Hz	50	А
	Magnetic Field	A/m (r.m.s.)	1	

#### 13.4. Test Procedure

The EUT and its load are placed on a table which is 0.8 meter above a metal ground plane measured at least 1m\*1m min. The test magnetic field shall be placed at central of the induction coil.

The test magnetic Field shall be applied 10 minutes by the immersion method to the EUT. And the induction coil shall be rotated by  $90^{\circ}$  in order to expose the EUT to the test field with different orientation (X, Y, Z Orientations).

#### 13.5. Deviation from Test Standard

No deviation.



Product	Network Camera		
Test Item	Power frequency magnetic field		
Test Mode	Mode 1: Normal Operation		
Date of Test	2011/03/16	Test Site	No.3 Shielded Room

Polarization	Frequency	Magnetic	Required	Performance	Test Result
	(Hz)	Strength	Performance	Criteria	
		(A/m)	Criteria	Complied To	
X Orientation	50	1	А	А	PASS
Y Orientation	50	1	A	A	PASS
Z Orientation	50	1	A	A	PASS

 $\boxtimes$   $\;$  Meet criteria A: Operate as intended during and after the test  $\;$ 

 $\hfill\square$  Meet criteria B: Operate as intended after the test

- □ Meet criteria C: Loss/Error of function
- □ Additional Information
  - EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at \_\_\_\_\_ kV of Line \_\_\_\_\_.
- No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.

## 13.7. Test Photograph

Test Mode : Mode 1: Normal Operation

Description : Power Frequency Magnetic Field Test Setup



## 14. Voltage Dips and Interruption

## 14.1. Test Specification

According to Standard : IEC 61000-4-11

### 14.2. Test Setup



## 14.3. Limit

Item	Environmental	Units	Test Specification	Performance
	Phenomena			Criteria
Input	AC Power Ports			
\ \	/oltage Dips	% Reduction	30	0
		Period	25	C
		% Reduction	>95	D
		Period	0.5	D
``	Voltage Interruptions	% Reduction	> 95	C
		Period	250	U

### 14.4. Test Procedure

The EUT and its load are placed on a table which is 0.8 meter above a metal ground plane measured 1m\*1m min. And 0.65mm thick min. And projected beyond the EUT by at least 0.1m on all sides. The power cord shall be used the shortest power cord as specified by the manufacturer.

For Voltage Dips/ Interruptions test:

The selection of test voltage is based on the rated power range. If the operation range is large than 20% of lower power range, both end of specified voltage shall be tested. Otherwise, the typical voltage specification is selected as test voltage.

The EUT is connected to the power mains through a coupling device that directly couples to the Voltage Dips and Interruption Generator.

The EUT shall be tested for 30% voltage dip of supplied voltage and duration 25 Periods, for 95% voltage dip of supplied voltage and duration 0.5 Periods with a sequence of three voltage dips with intervals of 10 seconds, and for 95% voltage interruption of supplied voltage and duration 250 Periods with a sequence of three voltage interruptions with intervals of 10 seconds.

Voltage phase shifting are shall occur at  $0^0$ ,  $45^0$ ,  $90^0$ ,  $135^0$ ,  $180^0$ ,  $225^0$ ,  $270^0$ ,  $315^0$  of the voltage.

#### 14.5. Deviation from Test Standard

No deviation.

Product	Network Camera		
Test Item	Voltage dips and interruption		
Test Mode	Mode 1: Normal Operation		
Date of Test	2011/03/16	Test Site	No.3 Shielded Room

Voltage Dips and	Angle	Test Duration	Required	Performance	Test Result
Interruption		(Periods)	Performance	Criteria	
Reduction(%)			Criteria	Complied To	
30	0	25	С	А	PASS
30	45	25	С	А	PASS
30	90	25	С	А	PASS
30	135	25	С	А	PASS
30	180	25	С	А	PASS
30	225	25	С	А	PASS
30	270	25	С	А	PASS
30	315	25	С	А	PASS
>95	0	0.5	В	А	PASS
>95	45	0.5	В	А	PASS
>95	90	0.5	В	А	PASS
>95	135	0.5	В	А	PASS
>95	180	0.5	В	А	PASS
>95	225	0.5	В	А	PASS
>95	270	0.5	В	А	PASS
>95	315	0.5	В	А	PASS
>95	0	250	С	С	PASS
>95	45	250	С	С	PASS
>95	90	250	С	С	PASS
>95	135	250	С	С	PASS
>95	180	250	С	С	PASS
>95	225	250	С	С	PASS
>95	270	250	С	С	PASS
>95	315	250	С	С	PASS

 $\boxtimes$   $\;$  Meet criteria A: Operate as intended during and after the test  $\;$ 

□ Meet criteria B: Operate as intended after the test

- Meet criteria C: Loss/Error of function
- □ Additional Information
  - ☐ The nominal voltage of EUT is 230V.
  - EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at \_\_\_\_\_ kV of Line \_\_\_\_\_.
- No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.

## 14.7. Test Photograph

Test Mode : Mode 1: Normal Operation Description : Voltage Dips Test Setup







### 15. Attachment

## > EUT Photograph

(1) EUT Photo



(2) EUT Photo





## (3) EUT Photo



(4) EUT Photo





### (5) EUT Photo



(6) EUT Photo

